



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants:

S. MAEDA et al.

Serial No.:

09/294,137

Filed:

April 20, 1999

For:

DEFECT INSPECTION METHOD AND APPARATUS

RECEIVED

Art Unit:

2621

DEC'1 8 2002

Examiner:

B. Werner

Technology Center 2600

AMENDMENT AFTER FINAL REJECTION

Box AF

December 16, 2002

Assistant Commissioner for Patents Washington, D.C. 20231

Sir:

In response to the <u>final</u> Office Action of May 13, 2002, and the Office communication of May 24, 2002, and further to the Notice of Appeal of October 15, 2002, please amend the above-identified application as follows.

No additional claim fee is due in connection with the filing of the present amendment.

IN THE CLAIMS

Amend claims 7-8, 15, 22, and 27 as follows:

locally not defined